Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/733,562	TUIJN ET AL.	
Examiner	Art Unit	
John M. Frink	2142	

	SEAR	CHED	
Class	Subclass	Date	Examiner
		,	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	
			-
·	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text search	8/23/2007	JMF
inventor search	8/23/2007	JMF